Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination YANO, KEIICHI Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-4,220,810 A	09-1980	Arai et al.	174/263
*	В	US-5,886,401 A	03-1999	Liu, Yung Sheng	257/678
*	С	US-2002/0102441 A1	08-2002	Shinosawa et al.	428/698
*	D	US-2002/0167017 A1	11-2002	Nakabayashi et al.	257/98
*	E	US-2003/0157437 A1	08-2003	Yamamoto et al.	430/311
*	F	US-2004/0188696 A1	09-2004	Hsing Chen et al.	257/099
*	G	US-2004/0262738 A1	12-2004	Lee et al.	257/700
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0				•	
	Р					
	Q					
	R					
	S					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	V	
	w	
	х	

A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.